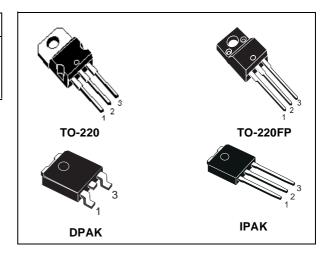


# STP4NK50Z - STP4NK50ZFP STD4NK50Z - STD4NK50Z-1

N-CHANNEL 500V - 2.4Ω - 3A TO-220/TO-220FP/DPAK/IPAK Zener-Protected SuperMESH™Power MOSFET

TYPE	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	Pw
STP4NK50Z	500 V	< 2.7 Ω	3 A	45 W
STP4NK50ZFP	500 V	< 2.7 Ω	3 A	20 W
STD4NK50Z	500 V	< 2.7 Ω	3 A	45 W
STD4NK50Z-1	500 V	< 2.7 Ω	3 A	45 W

- TYPICAL  $R_{DS}(on) = 2.3 \Omega$
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- GATE CHARGE MINIMIZED
- VERY LOW INTRINSIC CAPACITANCES
- VERY GOOD MANUFACTURING REPEATIBILITY

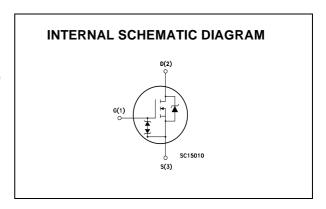


### **DESCRIPTION**

The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

### **APPLICATIONS**

- HIGH CURRENT, HIGH SPEED SWITCHING
- IDEAL FOR OFF-LINE POWER SUPPLIES, ADAPTORS AND PFC
- LIGHTING



### **ORDERING INFORMATION**

SALES TYPE	MARKING	PACKAGE	PACKAGING
STP4NK50Z	P4NK50Z	TO-220	TUBE
STP4NK50ZFP	P4NK50ZFP	TO-220FP	TUBE
STD4NK50ZT4	D4NK50Z	DPAK	TAPE & REEL
STD4NK50Z-1	D4NK50Z	IPAK	TUBE

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### STP4NK50Z - STP4NK50ZFP - STD4NK50Z - STD4NK50Z-1

### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter		Value		Unit
		STP4NK50Z	STP4NK50ZFP	STD4NK50Z STD4NK50Z-1	
$V_{DS}$	Drain-source Voltage (V <sub>GS</sub> = 0)		500		V
$V_{DGR}$	Drain-gate Voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		500		V
$V_{GS}$	Gate- source Voltage		± 30		V
I <sub>D</sub>	Drain Current (continuous) at T <sub>C</sub> = 25°C	3	3 (*)	3 (*)	Α
I <sub>D</sub>	Drain Current (continuous) at T <sub>C</sub> = 100°C	1.9	1.9 (*)	1.9 (*)	Α
I <sub>DM</sub> (•)	Drain Current (pulsed)	12	12 (*)	12 (*)	Α
P <sub>TOT</sub>	Total Dissipation at T <sub>C</sub> = 25°C	45	20	45	W
	Derating Factor	0.36	0.16	0.36	W/°C
V <sub>ESD(G-S)</sub>	Gate source ESD(HBM-C=100pF, R=1.5KΩ)		2800		V
dv/dt (1)	Peak Diode Recovery voltage slope	4.5		V/ns	
V <sub>ISO</sub>	Insulation Withstand Voltage (DC)	-	2500	-	V
T <sub>j</sub> T <sub>stg</sub>	Operating Junction Temperature Storage Temperature	-55 to 150		°C	

<sup>(•)</sup> Pulse width limited by safe operating area

### **THERMAL DATA**

		TO-220	TO-220FP	DPAK IPAK	
Rthj-case	Thermal Resistance Junction-case (Max)	2.78	6.25	2.78	°C/W
Rthj-amb	Thermal Resistance Junction-ambient (Max)	62	2.5	100	°C/W
T <sub>I</sub>	Maximum Lead Temperature For Soldering Purpose		300		°C

### **AVALANCHE CHARACTERISTICS**

Symbol	Parameter	Max Value	Unit
I <sub>AR</sub>	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by $T_j$ max)	3	А
E <sub>AS</sub>	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 50$ V)	120	mJ

### **GATE-SOURCE ZENER DIODE**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
BV <sub>GSO</sub>	Gate-Source Breakdown Voltage	Igs=± 1mA (Open Drain)	30			V

### PROTECTION FEATURES OF GATE-TO-SOURCE ZENER DIODES

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

<sup>(1)</sup> IsD  $\leq$ 3 A, di/dt  $\leq$ 200A/µs, VDD  $\leq$  V(BR)DSS, T<sub>i</sub>  $\leq$  TJMAX.

<sup>(\*)</sup> Limited only by maximum temperature allowed

# **ELECTRICAL CHARACTERISTICS** ( $T_{CASE} = 25^{\circ}C$ UNLESS OTHERWISE SPECIFIED) ON/OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	500			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max Rating V <sub>DS</sub> = Max Rating, T <sub>C</sub> = 125 °C			1 50	μA μA
I <sub>GSS</sub>	Gate-body Leakage Current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20V			±10	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 50\mu A$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static Drain-source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 1.5 A		2.3	2.7	Ω

### **DYNAMIC**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g <sub>fs</sub> (1)	Forward Transconductance	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 1.5 A		1.5		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V <sub>DS</sub> = 25V, f = 1 MHz, V <sub>GS</sub> = 0		310 49 10		pF pF pF
Coss eq. (3)	Equivalent Output Capacitance	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 400V$		33		pF

### SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on Delay Time Rise Time	$V_{DD}$ = 250 V, $I_D$ = 1.5 A $R_G$ = 4.7 $\Omega$ V <sub>GS</sub> = 10 V (Resistive Load see, Figure 3)		10 7		ns ns
$egin{array}{c} Q_{g} \ Q_{gs} \ Q_{gd} \end{array}$	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 400 \text{ V}, I_D = 3 \text{ A}, V_{GS} = 10 \text{ V}$		12 3 7		nC nC nC

### **SWITCHING OFF**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off Delay Time Fall Time	$V_{DD}$ = 250 V, $I_D$ = 1.5 A $R_G$ = 4.7 $\Omega$ V <sub>GS</sub> = 10 V (Resistive Load see, Figure 3)		21 11		ns ns
t <sub>r(Voff)</sub> t <sub>f</sub> t <sub>c</sub>	Off-voltage Rise Time Fall Time Cross-over Time	$V_{DD} = 400 \text{V}, I_D = 3 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{V}$ (Inductive Load see, Figure 5)		10 10 17		ns ns ns

### SOURCE DRAIN DIODE

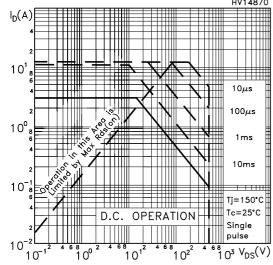
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SDM</sub> (2)	Source-drain Current Source-drain Current (pulsed)				3 12	A A
V <sub>SD</sub> (1)	Forward On Voltage	$I_{SD} = 3 A, V_{GS} = 0$			1.6	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 3$ A, di/dt = 100A/ $\mu$ s $V_{DD} = 40$ V, $T_j = 150$ °C (see test circuit, Figure 5)		260 935 7.2		ns nC A

Note: 1. Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5 %.

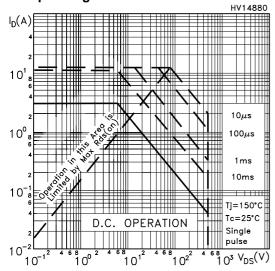
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r uise uuration = 300 µs, duty cycle 1.5 %.
 Pulse width limited by safe operating area.
 C<sub>oss eq.</sub> is defined as a constant equivalent capacitance giving the same charging time as C<sub>oss</sub> when V<sub>DS</sub> increases from 0 to 80% V<sub>DSs</sub>.

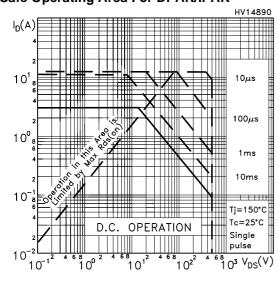
### Safe Operating For TO-220



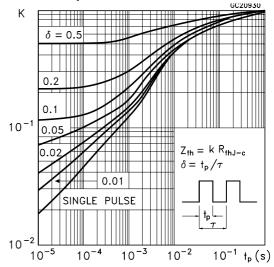
### Safe Operating Area For TO-220FP



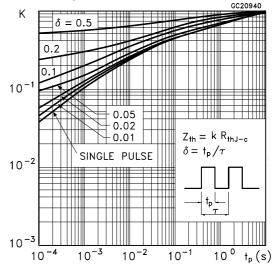
### Safe Operating Area For DPAK/IPAK



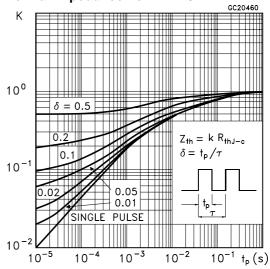
### **Thermal Impedance For TO-220**



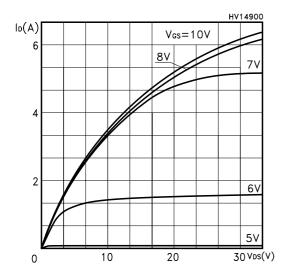
### Thermal Impedance For TO-220FP



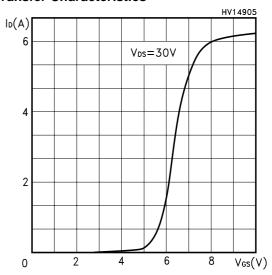
### Thermal Impedance For DPAK/IPAK



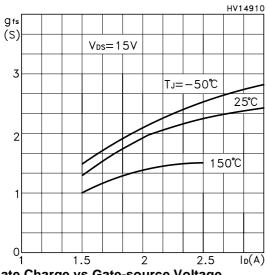
### **Output Characteristics**



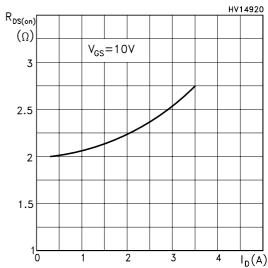
### **Transfer Characteristics**

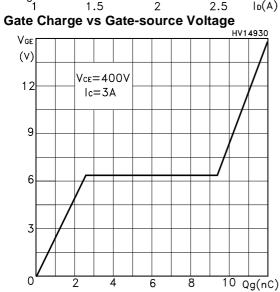


### **Transconductance**

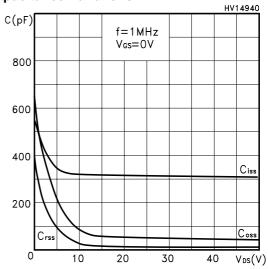


### **Static Drain-source On Resistance**



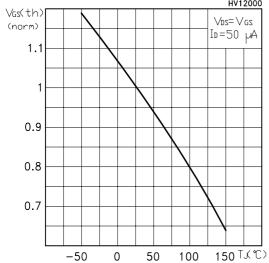


### **Capacitance Variations**

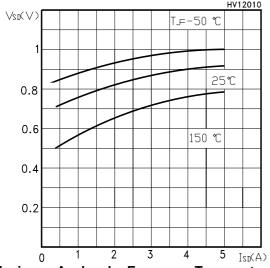


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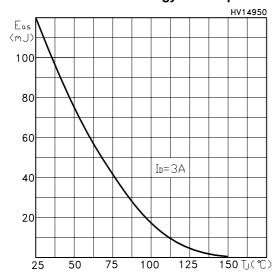
### Normalized Gate Threshold Voltage vs Temp.



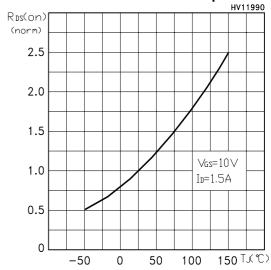
### **Source-drain Diode Forward Characteristics**



### Maximum Avalanche Energy vs Temperature



### Normalized On Resistance vs Temperature



### **Normalized BVDSS vs Temperature**

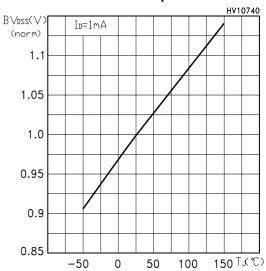


Fig. 1: Unclamped Inductive Load Test Circuit

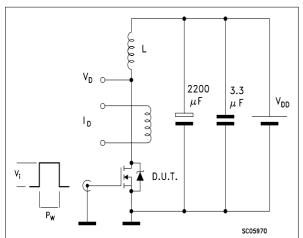


Fig. 3: Switching Times Test Circuit For

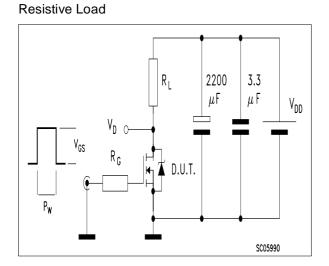


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times

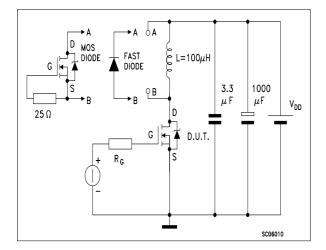


Fig. 2: Unclamped Inductive Waveform

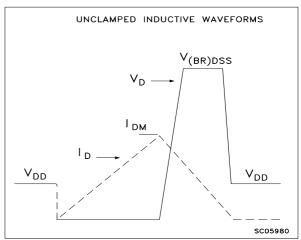
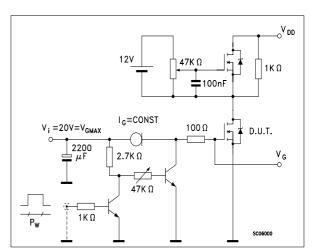
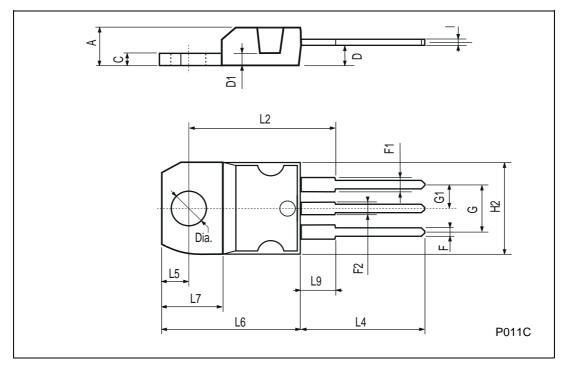


Fig. 4: Gate Charge test Circuit



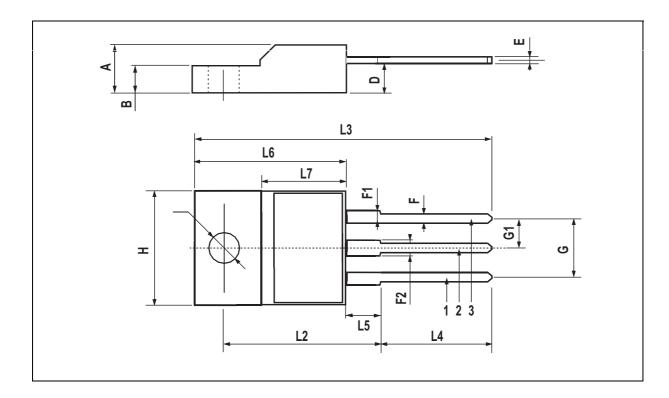
### **TO-220 MECHANICAL DATA**

DIM.		mm			inch	
DINI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.40		4.60	0.173		0.181
С	1.23		1.32	0.048		0.051
D	2.40		2.72	0.094		0.107
D1		1.27			0.050	
Е	0.49		0.70	0.019		0.027
F	0.61		0.88	0.024		0.034
F1	1.14		1.70	0.044		0.067
F2	1.14		1.70	0.044		0.067
G	4.95		5.15	0.194		0.203
G1	2.4		2.7	0.094		0.106
H2	10.0		10.40	0.393		0.409
L2		16.4			0.645	
L4	13.0		14.0	0.511		0.551
L5	2.65		2.95	0.104		0.116
L6	15.25		15.75	0.600		0.620
L7	6.2		6.6	0.244		0.260
L9	3.5		3.93	0.137		0.154
DIA.	3.75		3.85	0.147		0.151



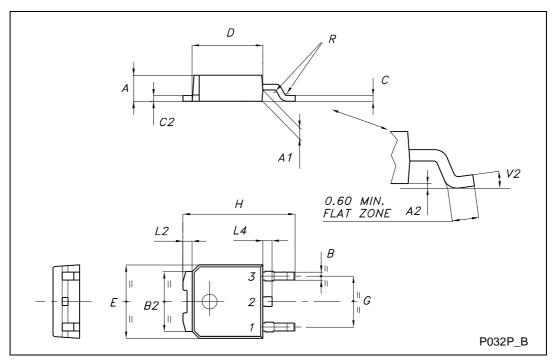
### **TO-220FP MECHANICAL DATA**

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.5	0.045		0.067
F2	1.15		1.5	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



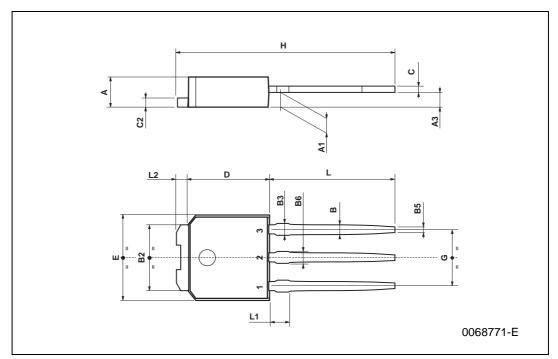
### **TO-252 (DPAK) MECHANICAL DATA**

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	2.20		2.40	0.087		0.094
A1	0.90		1.10	0.035		0.043
A2	0.03		0.23	0.001		0.009
В	0.64		0.90	0.025		0.035
B2	5.20		5.40	0.204		0.213
С	0.45		0.60	0.018		0.024
C2	0.48		0.60	0.019		0.024
D	6.00		6.20	0.236		0.244
Е	6.40		6.60	0.252		0.260
G	4.40		4.60	0.173		0.181
Н	9.35		10.10	0.368		0.398
L2		0.8			0.031	
L4	0.60		1.00	0.024		0.039
V2	0°		8°	0°		0°



### **TO-251 (IPAK) MECHANICAL DATA**

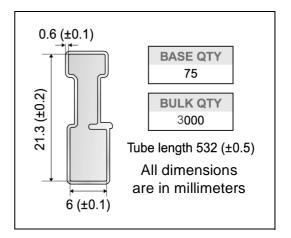
DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
А3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
В3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
E	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



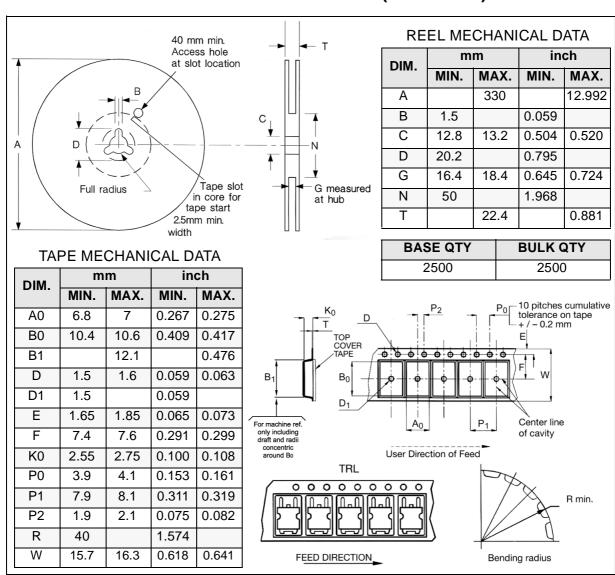
### **DPAK FOOTPRINT**

# 6.7 1.8 3.0 1.6 2.3 1.6 All dimensions are in millimeters

## **TUBE SHIPMENT (no suffix)\***



### TAPE AND REEL SHIPMENT (suffix "T4")\*



\* on sales type

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